

Notice of References Cited	Application/Control No. 10/056,426	Applicant(s)/Patent Under Reexamination KAWABE ET AL.	
	Examiner Sun J Lin	Art Unit 2825	Page 1 of 1

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	B	US-6,308,312 B1	10-2001	Houston	716/17
	C	US-6,687,883 B2	02-2004	Cohn et al.	716/4
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.